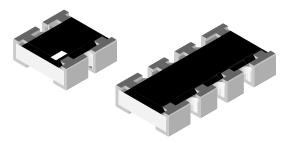


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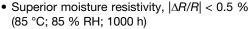
Precision Thin Film Chip Resistor Array Superior Moisture Resistivity

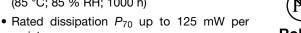


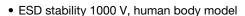
ACAS 0606 AT and ACAS 0612 AT precision automotive grade thin film chip resistor arrays with convex terminations combine the proven reliability of discrete chip resistors with the advantages of chip resistor arrays. Defined relative tolerance (matching) and relative TCR (tracking) make this product perfectly suited for applications with outstanding requirements towards stable fixed resistor ratios. The ACAS AT is available with equal or different resistor values. Find out more about Vishay's automotive grade product requirements at: www.vishay.com/applications

FEATURES

resistor







- Relative TCR down to ± 5 ppm/K (tracking)
- Relative tolerance down to ± 0.05 % (matching)
- AEC-Q200 qualified
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- · Precision analogue circuits
- Voltage divider
- Feedback circuits
- · Signal conditioning

DESCRIPTION	ACAS 0606 AT	ACAS 0612 AT		
EIA size	0606	0612		
Metric size	RR1616M	RR1632M		
Configuration, isolated	2 x 0603	4 x 0603		
Design:				
All equal values (AE)	AE	AE		
Two pairs of values (TP)		TP		
Different values (DF)	DF			
Resistance values	47 Ω to	150 kΩ ⁽¹⁾		
Absolute tolerance	± 0.	.1 %		
Relative tolerance	± 0.	05 %		
Absolute temperature coefficient	± 25 ppm/K; ± 15 j	opm/K; ± 10 ppm/K		
Relative temperature coefficient	± 15 ppm/K; ± 10	ppm/K; ± 5 ppm/K		
Max. resistance ratio $R_{\text{min.}}/R_{\text{max.}}$	1:	20		
Rated dissipation: P ₇₀				
Element	0.125 W	0.125 W		
Package	0.2 W	0.4 W		
Operating voltage, U _{max} . AC/DC	75	5 V		
Operating temperature range	- 55 °C to 155 °C			
Permissible film temperature	155 °C			
Insulation voltage (<i>U</i> _{ins}) against ambient and between integrated resistors, continuous	75	75 V		

Notes

- The relative figures of tolerance, TCR and drift are related to a medial axis between the maximum and minimum permissable deviation of
 the resistor array. For detailed information please refer to the application note: Increasing Accuracy in Feedback Circuits and Voltage
 Dividers with Thin Film Chip Resistor Arrays (www.vishay.com/doc?28194)
- (1) Resistance values to be selected from E24; E192.

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APPLICATION INFORMATION

The power dissipation on the resistor generates a temperature rise against the local ambient, depending on the heat flow support of the printed-circuit board (thermal resistance). The rated dissipation applies only if the permitted film temperature is not exceeded. These resistors do not feature a limited lifetime when operated within the permissible limits.

MAXIMUM RESISTANCE CHANGE AT RATED POWER (1)								
DESCRIPTION		ACAS 0	606 AT	ACAS 0612 AT				
Configuration, isolated		2 x 0	603	4 x (0603			
Operation mode		Standard	Power	Standard	Power			
Rated power per element, P ₇₀		0.1 W	0.125 W	0.1 W	0.125 W			
Rated power per package, P ₇₀	Rated power per package, P ₇₀		0.2 W	0.3 W	0.4 W			
Film temperature	Film temperature		155 °C	125 °C	155 °C			
Max. resistance change at P ₇₀								
$\Delta R/R$ max., after:	1000 h	± 0.1 %	± 0.25 %	± 0.1 %	± 0.25 %			
	8000 h	± 0.25 %	± 0.5 %	± 0.25 %	± 0.5 %			
Max. relative resistance change (relative drift) at P ₇₀								
$\Delta R/R$ max., after:	1000 h	± 0.05 %	± 0.125 %	± 0.05 %	± 0.125 %			
	8000 h	± 0.125 %	± 0.25 %	± 0.125 %	± 0.25 %			

Note

CIRCUITS



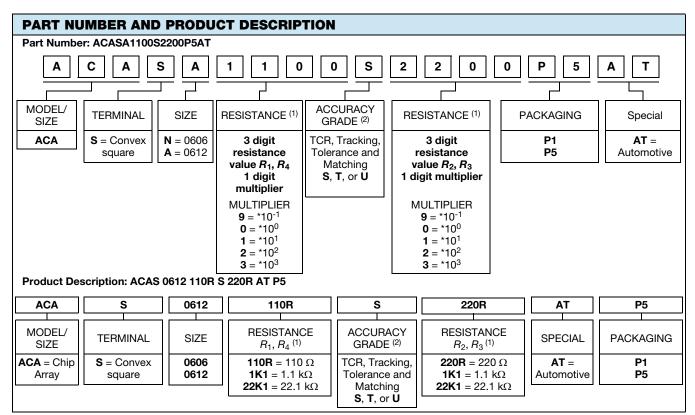
ACAS 0612 AT

Marking on ACAS 0606 AT: For types with different resistor values pin 1 is marked.

DESIGN						
	ACAS 0606 AT	ACAS 0612 AT				
AE	$R_1 = R_2$	$R_1 = R_2 = R_3 = R_4$				
TP		$R_1 = R_4 < R_2 = R_3$				
DF	R ₁ < R ₂					

⁽¹⁾ Figures are given for arrays with equal values, design type AE.

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Notes

- Products can be ordered using either the PART NUMBER or the PRODUCT DESCRIPTION.
- (1) $R_1 = R_4 \le R_2 = R_3$.
- (2) For historical temperature coefficient and resistance ranges please refer to the end of the data sheet.

TEMPERATURE COEFFICIENT AND RESISTANCE RANGE									
TYPE	ACCURACY	ABSO	LUTE	RELA	RESISTANCE				
ITPE	GRADE	TCR	TOLERANCE	TCR	TOLERANCE	VALUE			
	S	± 25 ppm/K	± 0.1 %	± 15 ppm/K	± 0.05 %	47 Ω to 150 k Ω			
ACAS 0606 AT ACAS 0612 AT	Т	± 15 ppm/K	± 0.1 %	± 10 ppm/K	± 0.05 %	47 Ω to 150 k Ω			
	U	± 10 ppm/K	± 0.1 %	± 5 ppm/K	± 0.05 %	47 Ω to 100 k Ω			

Notes

- For historical temperature coefficent and resistance range please refer to the end of the data sheet.
- Relative TCR (tracking) down to ± 2.5 ppm/K on request.
- Relative tolerance for resistance values < 80 Ω on request.

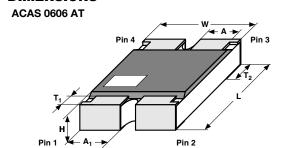


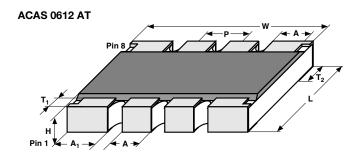
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PACKAGING									
TYPE	CODE	QUANTITY	PACKAGING STYLE	WIDTH	PITCH	REEL DIAMETER			
ACAS 0606 AT	P1	1000	Tape and reel cardboard tape	9 mm	4 mm	180 mm/7"			
ACAS 0612 AT	P5	5000	acc. IEC 60286-3 Type I	8 mm	4 mm				

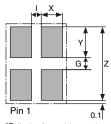
DIMENSIONS

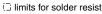


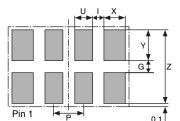


DIMENSION AND MASS									
TYPE	L (mm)	W (mm)	H (mm)	P (mm)	A ₁ (mm)	A (mm)	T ₁ (mm)	T ₂ (mm)	MASS (mg)
ACAS 0606 AT	1.5 ± 0.15	1.6 ± 0.15	0.45 ± 0.1	-	0.6 ± 0.1	0.4 ± 0.1	0.3 ± 0.15	0.4 ± 0.15	3.6
ACAS 0612 AT	1.5 ± 0.15	3.2 ± 0.15	0.45 ± 0.1	0.8 ± 0.1	0.6 ± 0.1	0.4 ± 0.1	0.3 ± 0.15	0.4 ± 0.15	6.8

PATTERN STYLES FOR CHIP RESISTOR ARRAYS







☐ limits for solder resist

Dimensions in mm

RECOMMENDED SOLDER PAD DIMENSIONS								
TYPE	G (mm)	Y (mm)	X (mm)	U (mm)	Z (mm)	l (mm)	P (mm)	
ACAS 0606 AT	0.7	0.7	0.64	-	2.1	0.3	0.8	
ACAS 0612 AT	0.7	0.7	0.64	0.5	2.1	0.3	0.8	

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DESCRIPTION

The production of the components is strictly controlled and follows an extensive set of instructions established for reproducibility. A homogeneous film of metal alloy is deposited on a high grade (Al₂O₃) ceramic substrate using a mask to separate the adjacent resistors and conditioned to achieve the desired temperature coefficient. Specially designed inner contacts are realized on both sides. A special laser is used to achieve the target value by smoothly cutting a meander groove in the resistive layer without damaging the ceramics.

The resistor elements are covered by a protective coating designed for electrical, mechanical and climatic protection. The terminations receive a final pure tin on nickel plating.

The result of the determined production is verified by an extensive testing procedure and optical inspection performed on 100 % of the individual chip resistors. Only accepted products are laid directly into the paper tape in accordance with **IEC 60286-3** ⁽³⁾.

ASSEMBLY

The resistors are suitable for processing on automatic SMD assembly systems. They are suitable for automatic soldering using reflow or vapour phase as shown in **IEC 61760-1** ⁽³⁾. The encapsulation is resistant to all cleaning solvents commonly used in the electronics industry, including alcohols, esters and aqueous solutions.

The suitability of conformal coatings, if applied, shall be qualified by appropriate means to ensure the long-term stability of the whole system. The resistors are RoHS compliant; the pure tin plating provides compatibility with lead (Pb)-free and lead-containing soldering processes. The permitted storage time is 20 years, whereas the solderability is specified for 2 years after production or requalification. The immunity of the plating against tin whisker growth has been proven under extensive testing.

All products comply with the **GADSL** ⁽¹⁾ and the **CEFIC-EECA-EICTA** ⁽²⁾ list of legal restrictions on hazardous substances. This includes full compliance with the following directives:

- 2000/53/EC End of Life Vehicle Directive (ELV) and Annex II (ELV II)
- 2011/65/EC Restriction of the use of Hazardous Substances directive (RoHS)
- 2002/96/EC Waste Electrical and Electronic Equipment Directive (WEEE)

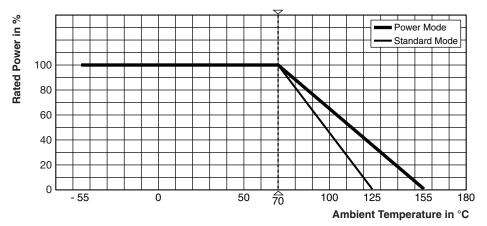
APPROVALS

The chip resistor array is AEC-Q200 qualified. Where applicable, the resistors are tested in accordance with **EN 140401-801** which refers to **EN 60115-1** and **EN 140400**.

Notes

- (1) Global Automotive Declarable Substance List, see www.gadsl.org.
- (2) CEFIC (European Chemical Industry Council), EECA (European Electronic Component Manufacturers Association), EICTA (European trade organisation representing the information and communications technology and consumer electronics), see www.eicta.org → policy → environmental policy group → chemicals → jig → Joint Industry Guide (JIG-101 Ed 2.0).
- (3) The quoted IEC standards are also released as EN standards with the same number and identical contents.

FUNCTIONAL PERFORMANCE



For permissible resistance change please refer to table MAXIMUM RESISTANCE CHANGE AT RATED POWER, above

Derating



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TESTS AND REQUIREMENTS

Essentially all tests are carried out in accordance with the following specifications:

EN 60115-1, generic specification

EN 140400, sectional specification

EN 140401-801, detail specification

The testing also covers most of the requirements specified by EIA/IS-703 and JIS-C-5202.

The tests are are carried out under standard atmospheric conditions according to **IEC 60068-1** ⁽¹⁾, 5.3. Climatic category LCT/UCT/56 (rated temperature range:

Lower category temperature, upper category temperature; damp heat, long term, 56 days) is valid (LCT = -55 °C/UCT = 125 °C).

Unless otherwise specified the following values apply:

Temperature: 15 °C to 35 °C Relative humidity: 45 % to 75 %

Air pressure: 86 kPa to 106 kPa (860 mbar to 1060 mbar)

The requirements stated in the "Test Procedures and Requirements" table are based on the required tests and permitted limits of EN 140401-801 where applicable.

TEST PROCEDURES AND REQUIREMENTS								
EN 60115-1 CLAUSE	IEC 60068-2 (1) TEST METHOD	TEST	PROCEDURE	REQUIREMENTS PERMISSIBLE CHANGE $^{(2)}$ (ΔR)				
			Stability for product types:					
			ACAS 0606 AT ACAS 0612 AT	47 Ω to 150 k Ω 47 Ω to 150 k Ω				
4.5	-	Resistance	-	± 0.1 %				
4.8.4.2	-	Temperature coefficient	At (20/- 55/ 20) °C and (20/125/20) °C	± 25 ppm/K; ± 15 ppm/K; ± 10 ppm/K				
			$U = \sqrt{P_{70} \times R}$ or $U = U_{\text{max.}}$; 1.5 h on; 0.5 h off; whichever is the less severe;					
4.25.1 -		Endurance at 70 °C: Standard operation mode	1000 h: Absolute Relative	\pm (0.1 % R + 0.05 Ω) \pm (0.05 % R + 0.05 Ω)				
			8000 h: Absolute Relative	\pm (0.25 % R + 0.05 Ω) \pm (0.125 % R + 0.05 Ω)				
	-		$U = \sqrt{P_{70} \times R}$ or $U = U_{\text{max.}}$; 1.5 h on; 0.5 h off; whichever is the less severe;					
		Endurance at 70 °C: Power operation mode	1000 h: Absolute Relative	\pm (0.25 % R + 0.05 Ω) \pm (0.125 % R + 0.05 Ω)				
			8000 h: Absolute Relative	\pm (0.5 % R + 0.05 Ω) \pm (0.25 % R + 0.05 Ω)				
			125 °C; 1000 h: Absolute Relative	\pm (0.25 % R + 0.05 Ω) \pm (0.125 % R + 0.05 Ω)				
4.25.3	-	Endurance at upper category temperature	125 °C; 8000 h: Absolute Relative	\pm (0.5 % R + 0.05 Ω) \pm (0.25 % R + 0.05 Ω)				
			155 °C; 1000 h: Absolute Relative	\pm (0.4 % R + 0.05 Ω) \pm (0.2 % R + 0.05 Ω)				
4.24	78 (Cab)	Damp heat, steady state	(40 ± 2) °C; 56 days; (93 ± 3) % RH	± (0.25 % R + 0.05 Ω)				
4.39	67 (Cy)	Damp heat, steady state, accelerated	$(85 \pm 2) ^{\circ}\text{C}$ $(85 \pm 5) ^{\circ}\text{RH}$ $U = \sqrt{0.1 \times P_{70} \times R};$ $U \le 0.3 \times U_{\text{max}};$ 1000 h	± (0.5 % R + 0.05 Ω)				

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TEST P	TEST PROCEDURES AND REQUIREMENTS								
EN 60115-1 CLAUSE	IEC 60068-2 ⁽¹⁾ TEST METHOD	TEST	PROCEDURE	REQUIREMENTS PERMISSIBLE CHANGE ⁽²⁾ (Δ <i>R</i>)					
			Stability for product types:						
			ACAS 0606 AT ACAS 0612 AT	47 Ω to 150 k Ω 47 Ω to 150 k Ω					
4.13	-	Short time overload ⁽³⁾ Standard operation mode	$U = 2.5 \times \sqrt{P_{70}} \times R$ or $U = 2 \times U_{\text{max.}}$; 5 s	\pm (0.1 % R + 0.01 $\Omega)$ no visible damage					
4.40	-	Electrostatic discharge (human body model) (3)	IEC 61340-3-1; 3 pos. + 3 neg. (equivalent to MIL-STD-883, Method 3015); 1000 V	$\pm~(0.5~\%~R+0.05~\Omega)$					
4.19	14 (Na)	Rapid change of temperature	30 min at - 55 °C and 30 min at 125 °C; 1000 cycles	\pm (0.25 % R + 0.05 Ω) no visible damage					
4.18.2	58 (Td)	Resistance to soldering heat	Reflow method 2 (IR/forced gas convection); (260 \pm 5) °C; (10 \pm 1) s	\pm (0.1 % R + 0.01 Ω) no visible damage					
4.17.2	EQ /Td/	Coldovskility	Solder bath method; SnPb; non-activated flux accelerated aging 4 h/155 °C (215 ± 3) °C; (3 ± 0.3) s	Good tinning (≥ 95 % covered);					
4.17.2	58 (Td)	Solderability	Solder bath method; SnAgCu; non-activated flux accelerated aging 4 h/155 °C (235 ± 3) °C; (2 ± 0.2) s	no visible damage					
4.32	21 (Ue ₃)	Shear (adhesion)	45 N	No visible damage					
4.33	21 (Ue ₁)	Substrate bending	Depth 2 mm, 3 times	\pm (0.1 % R + 0.01 Ω) no visible damage; no open circuit in bent position					
4.35	-	Flammability	IEC 60695-11-5, needle flame test; 10 s	No burning after 30 s					
4.22	6 (Fc)	Vibration	Endurance by sweeping; 10 Hz to 2000 Hz; no resonance; amplitude ≤ 1.5 mm or ≤ 200 m/s²; 7.5 h	\pm (0.1 % R + 0.01 Ω) no visible damage					
4.7	-	Voltage proof	$U_{\rm RMS} = U_{\rm ins}$ 60 s ± 5 s; against ambient, between adjacent resistors	No flashover or breakdown					

Notes

⁽³⁾ For a single element.

HISTORICAL	HISTORICAL TEMPERATURE COEFFICIENT AND RESISTANCE RANGES								
	DESCRIPTION								
ACCURACY GRADE	ABSOLUTE TCR	TCR TRACKING	ABSOLUTE TOLERANCE	TOLERANCE MATCHING	ACAS 0606 AT ACAS 0612 AT				
А	± 25 ppm/K	10 ppm/K	± 0.25 %	0.1 %	47 Ω to 150 k Ω				
В	± 25 ppm/K	10 ppm/K	± 0.5 %	0.25 %	47 Ω to 150 k Ω				
Е	± 25 ppm/K	15 ppm/K	± 0.25 %	0.1 %	47 Ω to 150 k Ω				
F	± 25 ppm/K	15 ppm/K	± 0.5 %	0.25 %	47 Ω to 150 k Ω				
J	± 25 ppm/K	25 ppm/K	± 0.25 %	0.1 %	47 Ω to 150 k Ω				
K	± 25 ppm/K	25 ppm/K	± 0.5 %	0.25 %	47 Ω to 150 k Ω				
N	± 50 ppm/K	25 ppm/K	± 0.5 %	0.5 %	47 Ω to 150 k Ω				
Р	± 50 ppm/K	50 ppm/K	± 0.5 %	0.5 %	47 Ω to 150 k Ω				

Note

⁽¹⁾ The quoted IEC standards are also released as EN standards with the same number and identical contents.

⁽²⁾ Figures are given for arrays with equal values, design type AE.

Special temperature coefficent and resistance combinations remain available. For optimized availability please refer to the table TEMPERATURE COEFFICENT AND RESISTANCE.



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M8340109K2002FCD03 M8340109MA010GHD03 EXB-24N121JX EXB-24N470JX EXB-A10E102J EXB-A10E104J 744C083101JTR

MDP1603100KGE04 PRA100I2-1KBWNW GUS-SS4-BLF-01-1002-G ACAS06S0830339P100 ACAS06S0830343P100

ACAS06S0830344P100 RM2012A-102/104-PBVW10 RM2012A-102503-PBVW10 RM3216B-102302-PBVW10 L091S102LF

ACAS06S0830341P100 ACAS06S0830342P100 ACAS06S0830345P100 EXB-14V300JX EXB-U18330JX EXB-V8V220GV PRA100I2
10KBWN PRA100I4-10KBWN M8340102M4701JAD04 M8340105K1002GGD03 M8340105M1001JCD03 M8340107K3402FCD03

M8340108K1000FGD03 M8340108K1000GGD03 M8340108K1002GGD03 M8340108K2002FCD03 M8340108K3901GGD03

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